Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10759719	LEE ET AL.
Examiner	**Art Unit**
SHIN-HON CHEN	2131

ORIGINAL

CLASS	SUBCLASS
380	256

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
380	256	259	282	30	
726	2	3			

INTERNATIONAL CLASSIFICATION

CLAIMED	NON-CLAIMED
H 04K 1/00 (2006.01.01)	G 06F 7/04 (2006.01.01)
H 04L 9/00 (2006.01.01)	G 06F 17/30 (2006.01.01)
H 04L 9/30 (2006.01.01)	G 06K 9/00 (2006.01.01)
	H 04L 9/32 (2006.01.01)

/SHIN-HON CHEN/ 7/18/08		Total Claims Allowed:
(Assistant Examiner) (Date)		13
/Ayaz Sheikh/ 07/22/08	O.G. Print Claim(s)	O.G. Print Figure
(Primary Examiner) (Date)	1	5